

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. <b>510.1114</b>	APPLICATION NO. <b>10/525 450</b> To be assigned
<b>LIST OF PRIOR ART CITED BY APPLICANT</b>  (Use several sheets if necessary)		APPLICANT <b>Markus WALTER</b>	
		FILING DATE Herewith	GROUP To be assigned

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
	A01	US 6,593,671	Jul. 15, 2003	SCHELL	307	87
	A02	US 2002/0182454	Dec. 5, 2002	AUTENRIETH et al.	429	9
	A03	US 6,380,638	Apr. 30, 2002	BITSCHE et al.	290	40
	A04					
	A05					
	A06					
	A07					
	A08					
	A09					

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
	A10	WO 03/054993	Jul. 3, 2003	WO - WIPO		In English	
	A11	EP 0 136 187	Apr. 3, 1985	EP - Europe		In English	
	A12	EP 1 225 082	Jul 24, 2002	EP - Europe		In English	
	A13	WO 99/46140	Sep. 16, 2004	WO - WIPO		English abstract, Corresponds to US 6,380,638	
	A14	WO 02/20300	Mar. 14, 2002	WO - WIPO		In English	
	A15	DE 199 32 781	Dec. 16, 2002	DE - Germany		English abstract; Corresponds to US 6,593,671	
	A16	DE 101 25 106	Dec. 5, 2002	DE - Germany		English abstract; Corresponds to US 2002/182,454	
	A17	DE 689 14 312 T2	May 11, 1994	DE - Germany		Translation of EP 0 334 474	
	A18	EP 0 334 474	Sep. 27, 1989	EP - Europe		In English	
	A19	JP 09 231991	Sep. 5, 1997	JP - Japan		English abstract; Search Report of PCT/DE03/002844	

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**

	A20	
	A21	
	A22	

<b>EXAMINER</b> /Alexander Chuang/	<b>DATE CONSIDERED</b> 09/25/2008
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.C./